

74HC574D

1. Functional Description

- Octal D-Type Flip Flop with 3-State Outputs

2. General

The 74HC574D is a high speed CMOS OCTAL FLIP-FLOP with 3-STATE OUTPUT fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

These 8-bit D-type flip-flops are controlled by a clock input (CK) and an output enable input (\overline{OE}).

When the \overline{OE} input is high, the eight outputs are in a high impedance state.

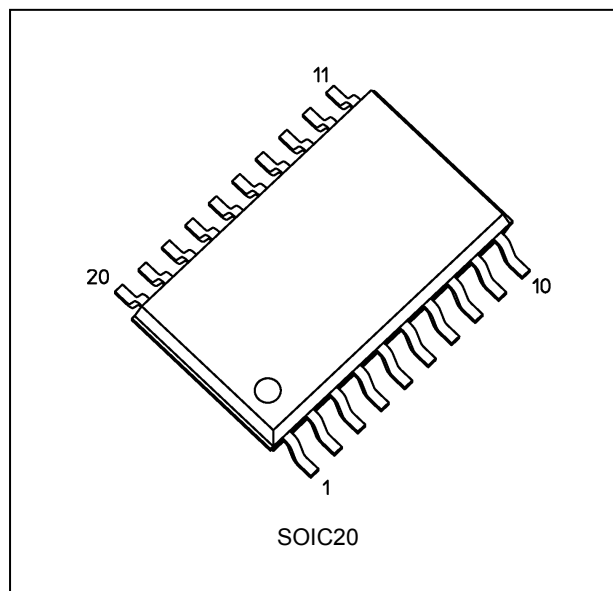
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

3. Features

- (1) Wide operating temperature range: $T_{opr} = -40$ to 125 °C (Note 1)
- (2) High speed: $f_{MAX} = 59$ MHz (typ.) at $V_{CC} = 6.0$ V
- (3) Low power dissipation: $I_{CC} = 4.0$ μ A (max) at $T_a = 25$ °C
- (4) Balanced propagation delays: $t_{PLH} \approx t_{PHL}$
- (5) Wide operating voltage range: $V_{CC(opr)} = 2.0$ V to 6.0 V

Note 1: Operating Range spec of $T_{opr} = -40$ °C to 125 °C is applicable only for the products which manufactured after July 2020.

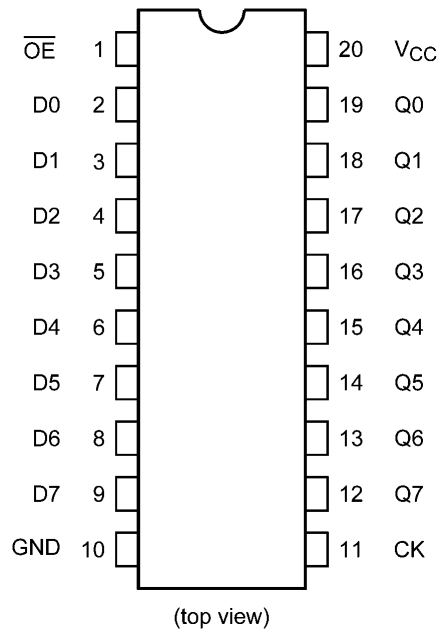
4. Packaging



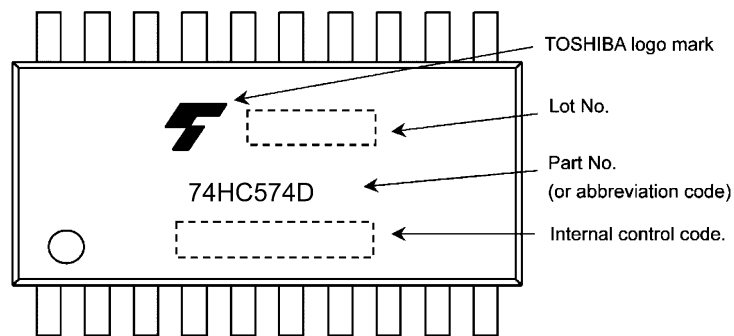
Start of commercial production

2020-07

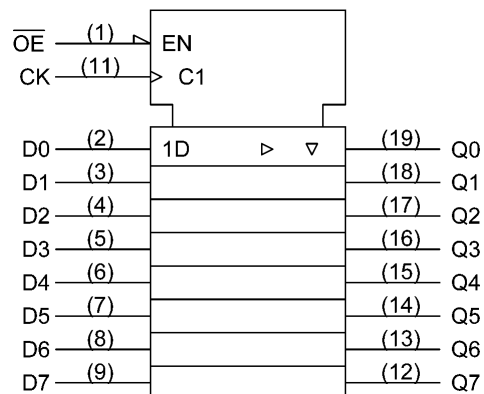
5. Pin Assignment






6. Marking



7. IEC Logic Symbol

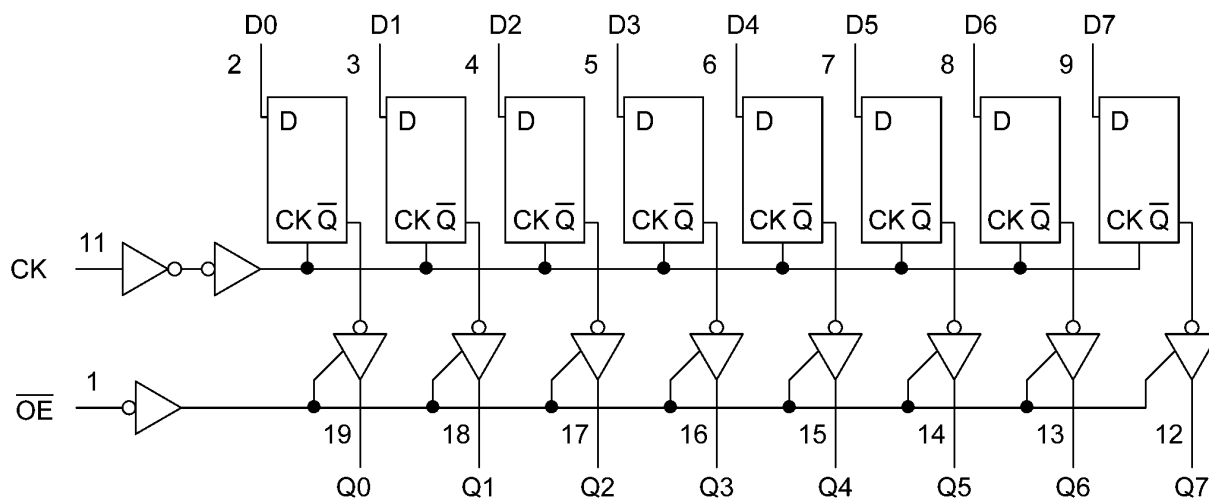


8. Truth Table

Inputs			Output
\overline{OE}	CK	D	
H	X	X	Z
L		X	Q _n
L		L	L
L		H	H

X: Don't care
 Z: High impedance
 Q_n: No change

9. System Diagram



10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V_{CC}		-0.5 to 7.0	V
Input voltage	V_{IN}		-0.5 to $V_{CC} + 0.5$	V
Output voltage	V_{OUT}		-0.5 to $V_{CC} + 0.5$	V
Input diode current	I_{IK}		± 20	mA
Output diode current	I_{OK}		± 20	mA
Output current	I_{OUT}		± 35	mA
V_{CC} /ground current	I_{CC}		± 75	mA
Power dissipation	P_D	(Note 1)	500	mW
Storage temperature	T_{stg}		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook (“Handling Precautions”/“Derating Concept and Methods”) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: P_D derates linearly with -8 mW/°C above 85 °C

11. Operating Ranges (Note)

Characteristics	Symbol	Note	Test Condition	Rating	Unit
Supply voltage	V_{CC}			2.0 to 6.0	V
Input voltage	V_{IN}			0 to V_{CC}	V
Output voltage	V_{OUT}			0 to V_{CC}	V
Operating temperature	T_{opr}	(Note 1)		-40 to 125	°C
Input rise and fall times	t_r, t_f		$V_{CC} = 2.0$ V	0 to 1000	ns
			$V_{CC} = 4.5$ V	0 to 500	
			$V_{CC} = 6.0$ V	0 to 400	
	(Note 1)	—	0 to 50	μ s	

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V_{CC} or GND.

Note 1: Operating Range spec of $T_{opr} = -40$ °C to 125 °C is applicable only for the products which manufactured after July 2020.

12. Electrical Characteristics

12.1. DC Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Min	Typ.	Max	Unit	
High-level input voltage	V_{IH}	—	2.0	1.50	—	—	V	
			4.5	3.15	—	—		
			6.0	4.20	—	—		
Low-level input voltage	V_{IL}	—	2.0	—	—	0.50	V	
			4.5	—	—	1.35		
			6.0	—	—	1.80		
High-level output voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -20\text{ }\mu\text{A}$	2.0	1.9	2.0	—	V
				4.5	4.4	4.5	—	
			6.0	5.9	6.0	—		
			$I_{OH} = -6\text{ mA}$	4.5	4.18	4.31	—	
6.0	5.68	5.80		—				
Low-level output voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 20\text{ }\mu\text{A}$	2.0	—	0.0	0.1	V
				4.5	—	0.0	0.1	
				6.0	—	0.0	0.1	
			$I_{OL} = 6\text{ mA}$	4.5	—	0.17	0.26	
				6.0	—	0.18	0.26	
3-state output OFF-state leakage current	I_{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND	6.0	—	—	± 0.5	μA	
Input leakage current	I_{IN}	$V_{IN} = V_{CC}$ or GND	6.0	—	—	± 0.1	μA	
Quiescent supply current	I_{CC}	$V_{IN} = V_{CC}$ or GND	6.0	—	—	4.0	μA	

12.2. DC Characteristics (Unless otherwise specified, $T_a = -40$ to $85\text{ }^\circ\text{C}$)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Min	Max	Unit	
High-level input voltage	V_{IH}	—	2.0	1.50	—	V	
			4.5	3.15	—		
			6.0	4.20	—		
Low-level input voltage	V_{IL}	—	2.0	—	0.50	V	
			4.5	—	1.35		
			6.0	—	1.80		
High-level output voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -20\text{ }\mu\text{A}$	2.0	1.9	—	V
				4.5	4.4	—	
			6.0	5.9	—		
			$I_{OH} = -6\text{ mA}$	4.5	4.13	—	
6.0	5.63	—					
Low-level output voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 20\text{ }\mu\text{A}$	2.0	—	0.1	V
				4.5	—	0.1	
				6.0	—	0.1	
			$I_{OL} = 6\text{ mA}$	4.5	—	0.33	
				6.0	—	0.33	
3-state output OFF-state leakage current	I_{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND	6.0	—	± 5.0	μA	
Input leakage current	I_{IN}	$V_{IN} = V_{CC}$ or GND	6.0	—	± 1.0	μA	
Quiescent supply current	I_{CC}	$V_{IN} = V_{CC}$ or GND	6.0	—	40.0	μA	

12.3. DC Characteristics (Note) (Unless otherwise specified, $T_a = -40$ to 125 °C)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Min	Max	Unit	
High-level input voltage	V_{IH}	—	2.0	1.50	—	V	
			4.5	3.15	—		
			6.0	4.20	—		
Low-level input voltage	V_{IL}	—	2.0	—	0.50	V	
			4.5	—	1.35		
			6.0	—	1.80		
High-level output voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -20 \mu A$	2.0	1.9	—	V
				4.5	4.4	—	
				6.0	5.9	—	
			$I_{OH} = -6$ mA	4.5	3.7	—	
Low-level output voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 20 \mu A$	2.0	—	0.1	V
				4.5	—	0.1	
				6.0	—	0.1	
			$I_{OL} = 6$ mA	4.5	—	0.4	
			$I_{OL} = 7.8$ mA	6.0	—	0.4	
3-state output OFF-state leakage current	I_{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND	6.0	—	± 5.0	μA	
Input leakage current	I_{IN}	$V_{IN} = V_{CC}$ or GND	6.0	—	± 1.0	μA	
Quiescent supply current	I_{CC}	$V_{IN} = V_{CC}$ or GND	6.0	—	80.0	μA	

Note: Operating Range spec of $T_{opr} = -40$ °C to 125 °C is applicable only for the products which manufactured after July 2020.

12.4. Timing Requirements (Unless otherwise specified, $T_a = 25\text{ °C}$, Input: $t_r = t_f = 6\text{ ns}$)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Typ.	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}, t_{w(H)}$	—	2.0	—	75	ns
			4.5	—	15	
			6.0	—	13	
Minimum setup time (Dn)	t_s	—	2.0	—	75	ns
			4.5	—	15	
			6.0	—	13	
Minimum hold time (Dn)	t_h	—	2.0	—	0	ns
			4.5	—	0	
			6.0	—	0	
Clock frequency	f	—	2.0	—	6	MHz
			4.5	—	31	
			6.0	—	36	

12.5. Timing Requirements (Unless otherwise specified, $T_a = -40\text{ to }85\text{ °C}$, Input: $t_r = t_f = 6\text{ ns}$)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}, t_{w(H)}$	—	2.0	95	ns
			4.5	19	
			6.0	16	
Minimum setup time (Dn)	t_s	—	2.0	95	ns
			4.5	19	
			6.0	16	
Minimum hold time (Dn)	t_h	—	2.0	0	ns
			4.5	0	
			6.0	0	
Clock frequency	f	—	2.0	5	MHz
			4.5	24	
			6.0	28	

12.6. Timing Requirements (Note) (Unless otherwise specified, $T_a = -40\text{ to }125\text{ °C}$, Input: $t_r = t_f = 6\text{ ns}$)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}, t_{w(H)}$	—	2.0	108	ns
			4.5	22	
			6.0	18	
Minimum setup time (Dn)	t_s	—	2.0	108	ns
			4.5	22	
			6.0	18	
Minimum hold time (Dn)	t_h	—	2.0	0	ns
			4.5	0	
			6.0	0	
Clock frequency	f	—	2.0	4	MHz
			4.5	19	
			6.0	23	

Note: Operating Range spec of $T_{opr} = -40\text{ °C}$ to 125 °C is applicable only for the products which manufactured after July 2020.

12.7. AC Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$, Input: $t_r = t_f = 6\text{ ns}$)

Characteristics	Symbol	Note	Test Condition	C_L (pF)	V_{CC} (V)	Min	Typ.	Max	Unit
Output transition time	t_{TLH}, t_{THL}		—	50	2.0	—	25	60	ns
					4.5	—	7	12	
					6.0	—	6	10	
Propagation delay time (CK-Q)	t_{PLH}, t_{PHL}		—	50	2.0	—	70	150	ns
					4.5	—	20	30	
					6.0	—	15	26	
				150	2.0	—	88	190	
					4.5	—	25	38	
					6.0	—	19	33	
Output enable time	t_{PZL}, t_{PZH}		$R_L = 1\text{ k}\Omega$	50	2.0	—	48	125	ns
					4.5	—	15	25	
					6.0	—	12	21	
				150	2.0	—	60	165	
					4.5	—	20	33	
					6.0	—	16	28	
Output disable time	t_{PLZ}, t_{PHZ}		$R_L = 1\text{ k}\Omega$	50	2.0	—	34	125	ns
					4.5	—	17	25	
					6.0	—	15	21	
Maximum clock frequency	f_{MAX}		—	50	2.0	6	17	—	MHz
					4.5	31	50	—	
					6.0	36	59	—	
Input capacitance	C_{IN}		—			—	5	10	pF
Output capacitance	C_{OUT}		—			—	10	—	pF
Power dissipation capacitance	C_{PD}	(Note 1)	—			—	54	—	pF

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$$I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/8 \text{ (per latch)}$$

And the total C_{PD} when n pcs of latch operate can be gained by the following equation.

$$C_{PD} \text{ (total)} = 39 + 15 \times n$$

12.8. AC Characteristics

(Unless otherwise specified, $T_a = -40$ to 85 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	C_L (pF)	V_{CC} (V)	Min	Max	Unit
Output transition time	t_{TLH}, t_{THL}	—	50	2.0	—	75	ns
				4.5	—	15	
				6.0	—	13	
Propagation delay time (CK-Q)	t_{PLH}, t_{PHL}	—	50	2.0	—	190	ns
				4.5	—	38	
				6.0	—	33	
			150	2.0	—	240	
				4.5	—	48	
				6.0	—	41	
Output enable time	t_{PZL}, t_{PZH}	$R_L = 1$ k Ω	50	2.0	—	155	ns
				4.5	—	31	
				6.0	—	26	
			150	2.0	—	205	
				4.5	—	41	
				6.0	—	35	
Output disable time	t_{PLZ}, t_{PHZ}	$R_L = 1$ k Ω	50	2.0	—	155	ns
				4.5	—	31	
				6.0	—	26	
Maximum clock frequency	f_{MAX}	—	50	2.0	5	—	MHz
				4.5	24	—	
				6.0	28	—	
Input capacitance	C_{IN}	—			—	10	pF

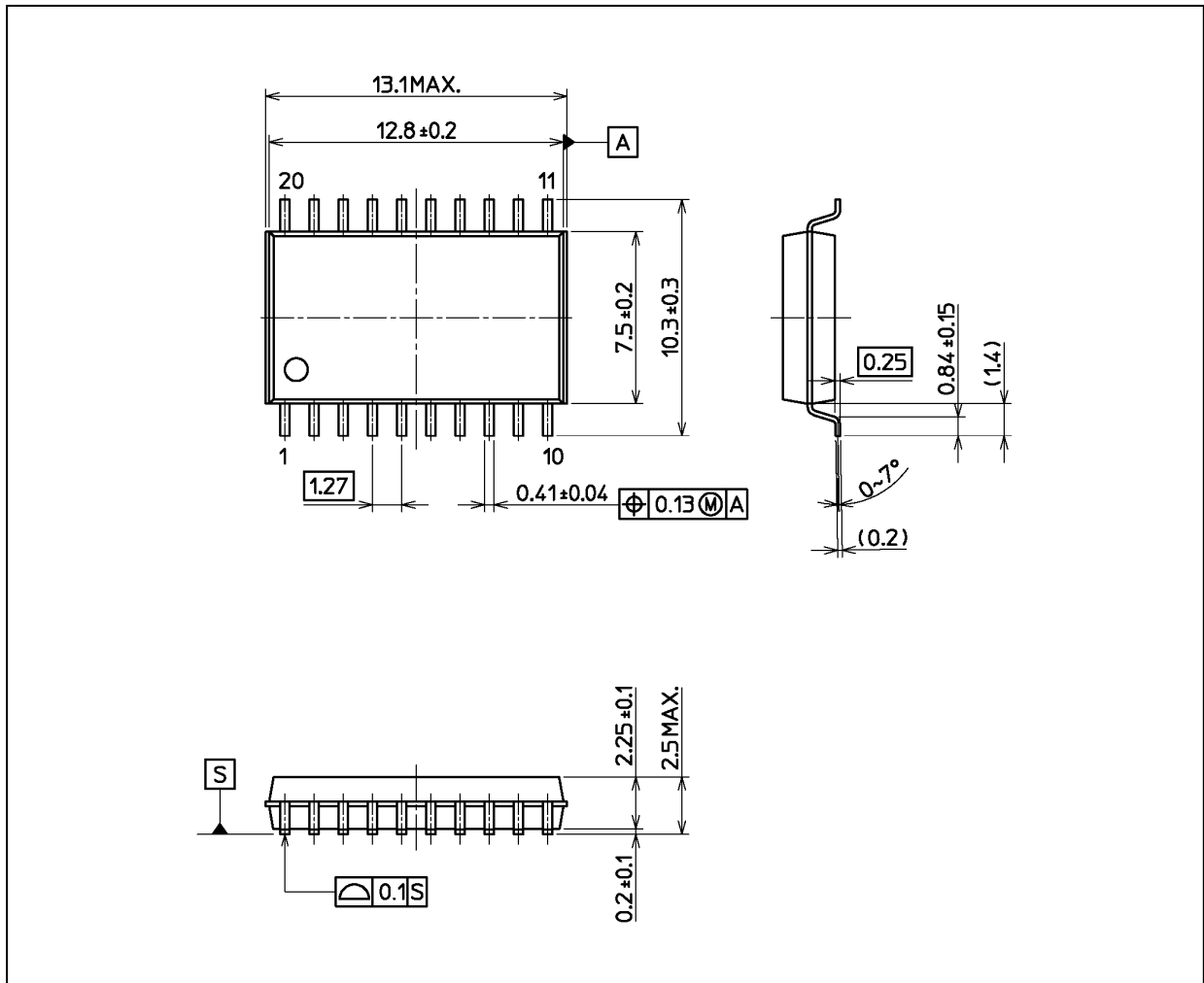
12.9. AC Characteristics (Note) (Unless otherwise specified, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V_{CC} (V)	C_L (pF)	Min	Max	Unit
Output transition time	t_{TLH}, t_{THL}	—	2.0	50	—	85	ns
			4.5		—	17	
			6.0		—	15	
Propagation delay time (CK-Q)	t_{PLH}, t_{PHL}	—	2.0	50	—	217	ns
			4.5		—	43	
			6.0		—	38	
			2.0	150	—	273	
			4.5		—	55	
			6.0		—	46	
Output enable time	t_{PZL}, t_{PZH}	$R_L = 1$ k Ω	2.0	50	—	175	ns
			4.5		—	35	
			6.0		—	29	
			2.0	150	—	232	
			4.5		—	46	
			6.0		—	40	
Output disable time	t_{PLZ}, t_{PHZ}	$R_L = 1$ k Ω	2.0	50	—	175	ns
			4.5		—	35	
			6.0		—	29	
Maximum clock frequency	f_{MAX}	—	2.0	50	4	—	MHz
			4.5		19	—	
			6.0		23	—	
Input capacitance	C_{IN}	—			—	10	pF

Note: Operating Range spec of $T_{opr} = -40$ °C to 125 °C is applicable only for the products which manufactured after July 2020.

Package Dimensions

Unit: mm



Weight: 0.51 g (typ.)

Package Name(s)
Nickname: SOIC20

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